Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/765,236	RATH, MATTHIAS
Examiner	Art Unit
Brian S. Kwon	1614

	SEARCHED				
Class	Subclass	Date	Examiner		
514	474	3/6/2006	ВК		
	725				
	458				
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424	655				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCH		·)
	DATE	EXMR
STN(resistry, caplus), EAST, NPL	3/26/2006	BLK
Continurity Data-09/70609		
Inventor Name Search		
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